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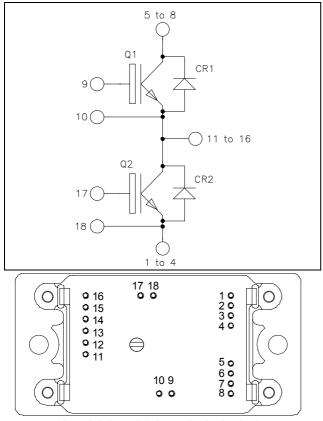
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# APTGT200A602G

Phase leg Trench + Field Stop IGBT3 Power Module



Pins 1/2/3/4 ; 5/6/7/8 ; 11/12/13/14/15/16 must be shorted together

# $V_{CES} = 600V$ $I_{C} = 200A$ @ Tc = 80°C

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Fast Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration

### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- RoHS Compliant

# All ratings (a) $T_i = 25^{\circ}C$ unless otherwise specified

## Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		600	V
I <sub>C</sub>	Continuous Collector Current	$T_C = 25^{\circ}C$	290	
	Continuous Conector Current	$T_C = 80^{\circ}C$	200	А
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	400	
$V_{GE}$	Gate – Emitter Voltage		$\pm 20$	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	625	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	400A @ 550V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com APTGT200A602G - Rev 1 October 2012



# **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				50	μA
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
		$I_{\rm C} = 200 {\rm A}$ $T_{\rm j} =$	$T_{j} = 150^{\circ}C$		1.7		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 2 \text{ mA}$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

# **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			12.3		
Coes	Output Capacitance	$V_{CE} = 25V$			0.8		nF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz			0.4		
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> =±15V, I <sub>C</sub> =20 V <sub>CE</sub> =300V	0A		2.1		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching	ng (25°C)		115		
T <sub>r</sub>	Rise Time	$V_{GE} = \pm 15 V$			45		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 200A$ $R_{G} = 2\Omega$			225		ns
$T_{\rm f}$	Fall Time				55		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 200A$ $R_G = 2\Omega$			130		ns
T <sub>r</sub>	Rise Time				50		
T <sub>d(off)</sub>	Turn-off Delay Time				300		
T <sub>f</sub>	Fall Time				70		
Eon	Turn on Energy	$V_{GE} = \pm 15V$	$T_j = 25^{\circ}C$		1		mJ
Lon	Turn on Energy	$V_{Bus} = 300V$	$T_j = 150^{\circ}C$		1.8		1115
Б	Turn off Energy		$T_j = 25^{\circ}C$		5.7		mJ
E <sub>off</sub>		$R_G = 2\Omega$ $T_j = 150^{\circ}C$			7		1115
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 360V$ $t_p \le 6\mu s$ ; $T_i = 150^{\circ}C$			1000		А
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.24	°C/W

# Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	$V_{R} = 600V$				50	μA
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		200		Α
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 200 {\rm A}$	$T_i = 25^{\circ}C$	-	1.6	2	v
<b>v</b> F		$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.5		
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 25^{\circ}C$		130		ns
		$I_{\rm F} = 200 \text{A}$ $V_{\rm R} = 300 \text{V}$ $T_{\rm j} = 25$	$T_{j} = 150^{\circ}C$		225		
Q <sub>rr</sub> Reverse Recov	Daviance Bacavany Change		$T_j = 25^{\circ}C$		9		C
	Reverse Recovery Charge		$T_{i} = 150^{\circ}C$		19		μC
Er	Reverse Recovery Energy		$T_j = 25^{\circ}C$		2.3		mJ
			$T_{j} = 150^{\circ}C$		4.7		111J
$R_{thJC}$	Junction to Case Thermal Resistance					0.4	°C/W

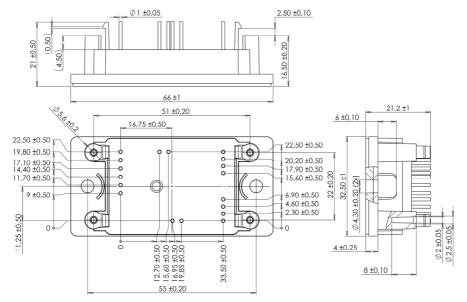


# APTGT200A602G

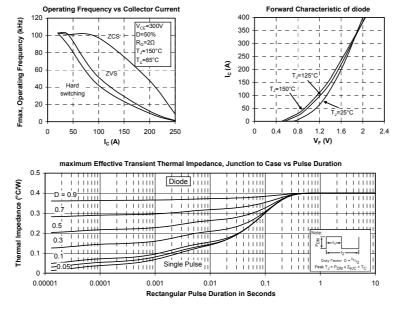
# Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range			-40		175	
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					75	g

### SP2 Package outline (dimensions in mm)



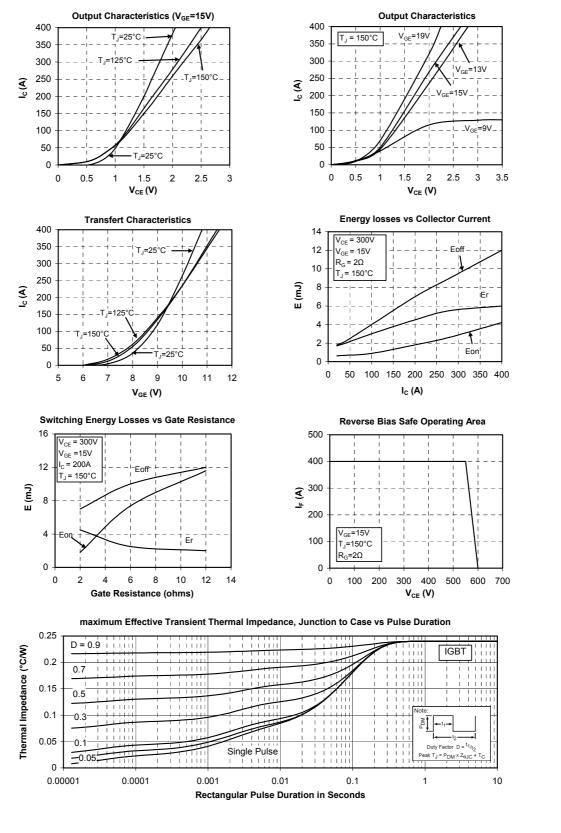
### **Typical Performance Curve**



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